

Notice of References Cited	Application/Control No. 10/591,945	Applicant(s)/Patent Under Reexamination FUJISAWA ET AL.	
	Examiner Nicholas Ieva	Art Unit 2836	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,431,112 B1	08-2002	Sill et al.	118/723E
*	B	US-6,563,076 B1	05-2003	Benjamin et al.	219/121.54
*	C	US-6,768,627 B1	07-2004	Kitabayashi et al.	361/234
*	D	US-6,104,596 A	08-2000	Hausmann, Gilbert	361/234
*	E	US-5,103,367	04-1992	Horwitz et al.	361/234
*	F	US-2001/0046112 A1	11-2001	HERCHEN, HARALD	361/234
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2004-31594 A	01-2004	JP	Yasushi, Uda	H01I021/61
	O	JP 9-293775 A	11-1997	JP	Shirosaki, Tomohide	H01I021/68
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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